

MIUON PROFILE DETECTORS

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CERN - SL/BI

M. Placidi MuCool Instrumentation Workshop - IIT / Chicago - Nov.10-11, 2000

INTRODUCTION

Beam Diagnostics in future High Energy Accelerators will require

- * long lived Instrumentation in
- * highly hostile radiation environment.

Detectors capable of

- withstand extreme radiation levels
- requiring no human intervention
- operate at frontiers of radiation-resistant technology

are at a prime for applications in environmental-hostile situations.

A research program aiming at

- individuating new solutions and technologies
- testing them under extreme operational conditions

has been launched at CERN in the framework of LHC developments.

**Preliminary Ideas are presented for possible applications
in Muon Beams Diagnostics for future Neutrino Factories.**

2 -A semi-invasive CdTe-based μ -profile monitor

MIP's create charges in CdTe and other semiconductors

PARAMETER			DETECTOR			
			CdTe	GaAs	Si	C (Diamond)
Thickness	τ	μm	300	300	300	300
Atomic number	Z		48/50	31/33	14	6
Density	ρ	g cm^{-3}	5.83	5.32	2.33	2.88
Rad. thickness	$\rho\tau$	g cm^{-2}	0.176	0.160	0.070	0.086
Energy loss rate	$-(dE/dx)_{min}$	$\text{MeV g}^{-1} \text{cm}^2$	1.26	1.40	1.66	1.78
Energy loss	ΔE	MeV	0.222	0.224	0.116	0.153
Ionization potential	I_o	eV	4.43	4.20	3.61	13.0
Charges/MIP inside Det. ^(*)	$N_q = \Delta E/I_o$	$\times 10^3$	50	53	32.2	11.85

(*) See later for Collection Efficiency

2 - A semi-invasive CdTe-based μ -profile monitor / Basic Idea

- Array of 10×10 CdTe elements ($2 \text{ cm}^2 \times 50\text{-}200 \mu\text{m}$)
- A 0.3 mm Al_2O_3 support (3.3×10^{-3} r.l.) covering $20 \times 20 \text{ cm}^2$ μ -beam section
- Remotely controlled to be inserted in beam
- Provides 2D profile measurements via charge collection on each CdTe element
- From (3) expect a charge per element proportional to a μ -flux

$$\langle \Delta N_\mu \rangle \simeq 2 \times 10^9 \mu/\text{burst}/\text{element}$$

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- CERN will complement LETI's expertise in technical realization of CdTe elements, deposit techniques, bonding on adequate supports, etc.

- Prototypes will be tested at CERN/SPS H4 450 GeV proton beam mid-2001 for
 1. charge collection efficiency and comparison with predictions,
 2. cross-talk detection between adjacent CdTe elements,
 3. front-end electronics requirements and performance.

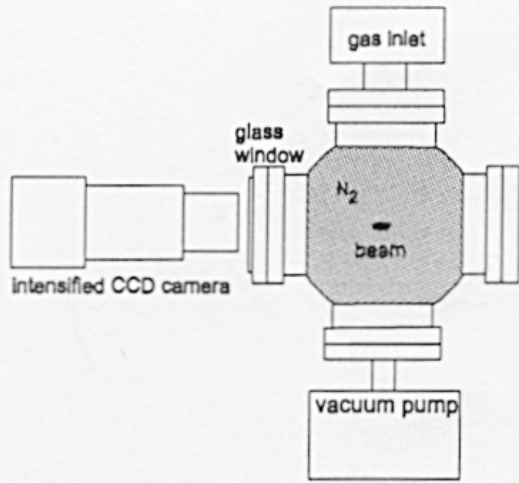
- Performance tests after irradiation in high neutron and proton fluxes are planned.

M.Placidi / IIT Meeting/Chicago, 11.13.2000

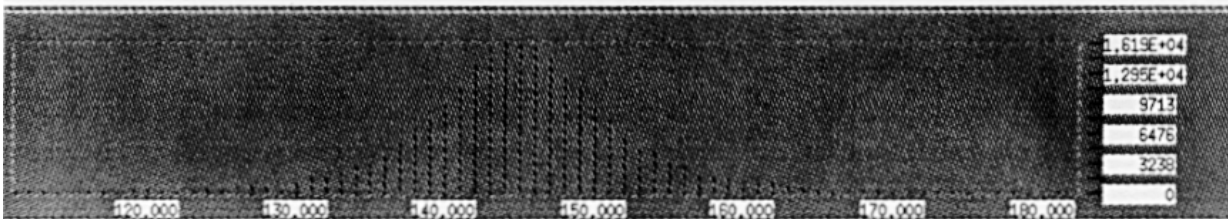
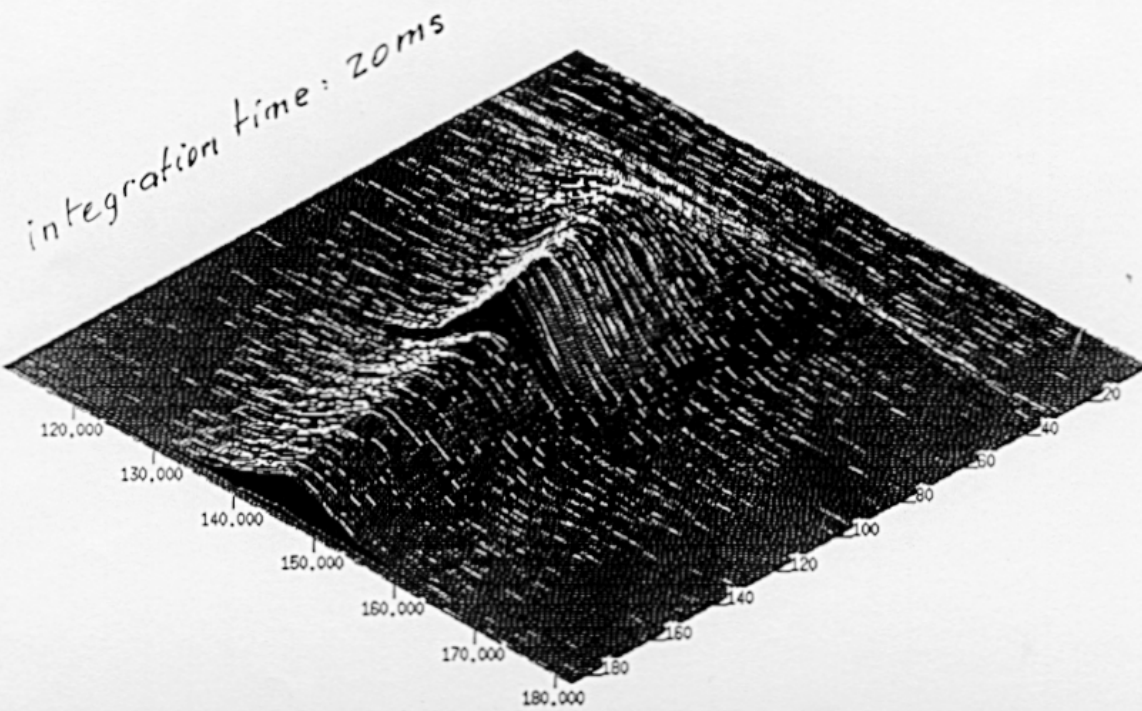
/tex/talks/chicago_00/mu_det.ps

LSS4 Luminescence Gas Test Monitor

(60 ns decay time)



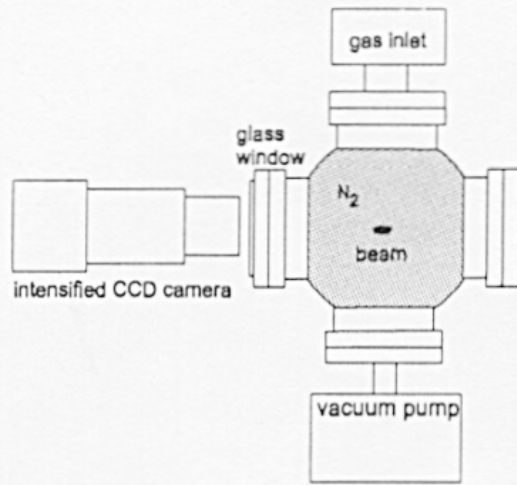
$$I_b = 2 \times 10^{13} \rho$$



$$\sigma = 860 \mu m$$

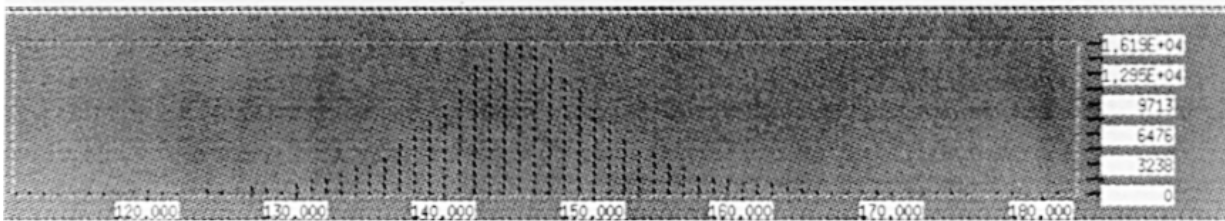
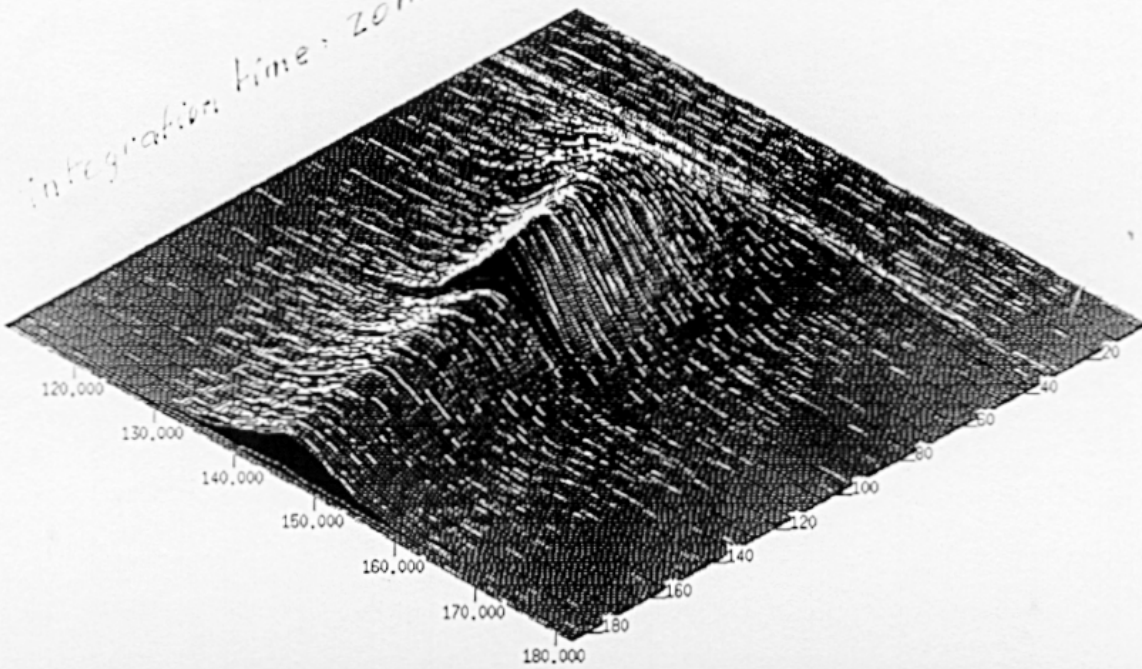
Preliminary results with Nitrogen at 10^{-5} to 10^{-6} Torr

LSS4 Luminescence Gas Test Monitor



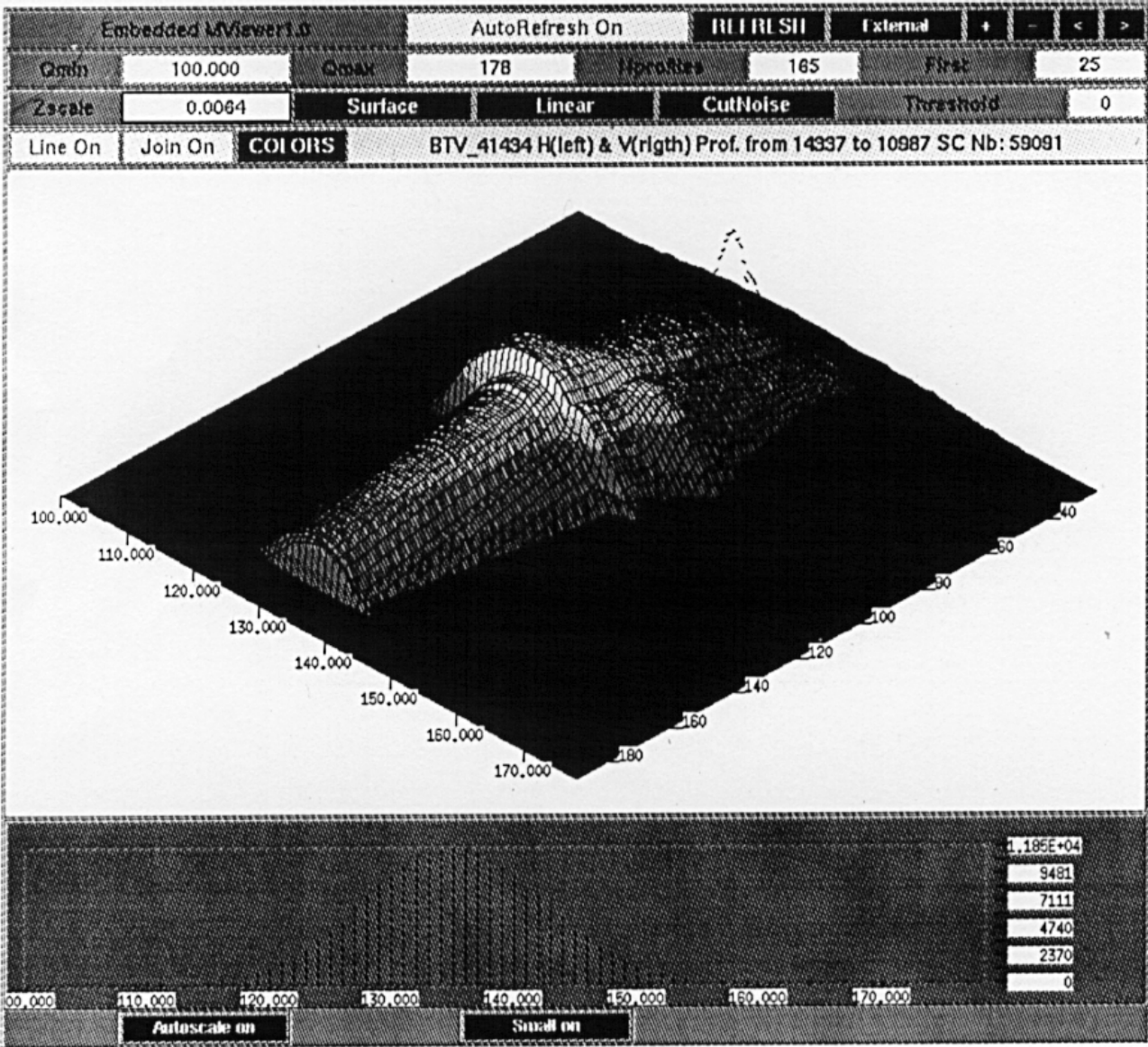
$$I_b = 2 \times 10^{13} \text{ p}$$

Integration time: 20ms



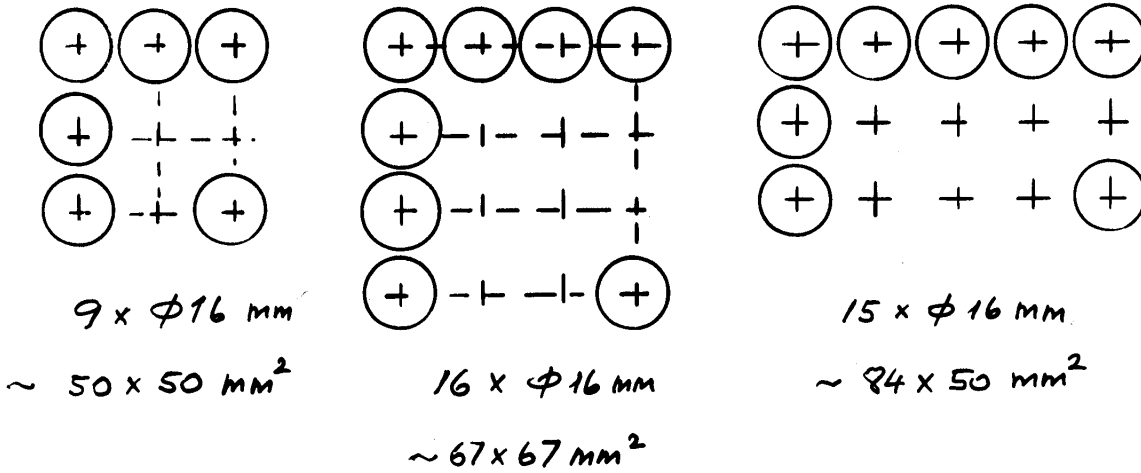
$$r = 860 \mu\text{m}$$

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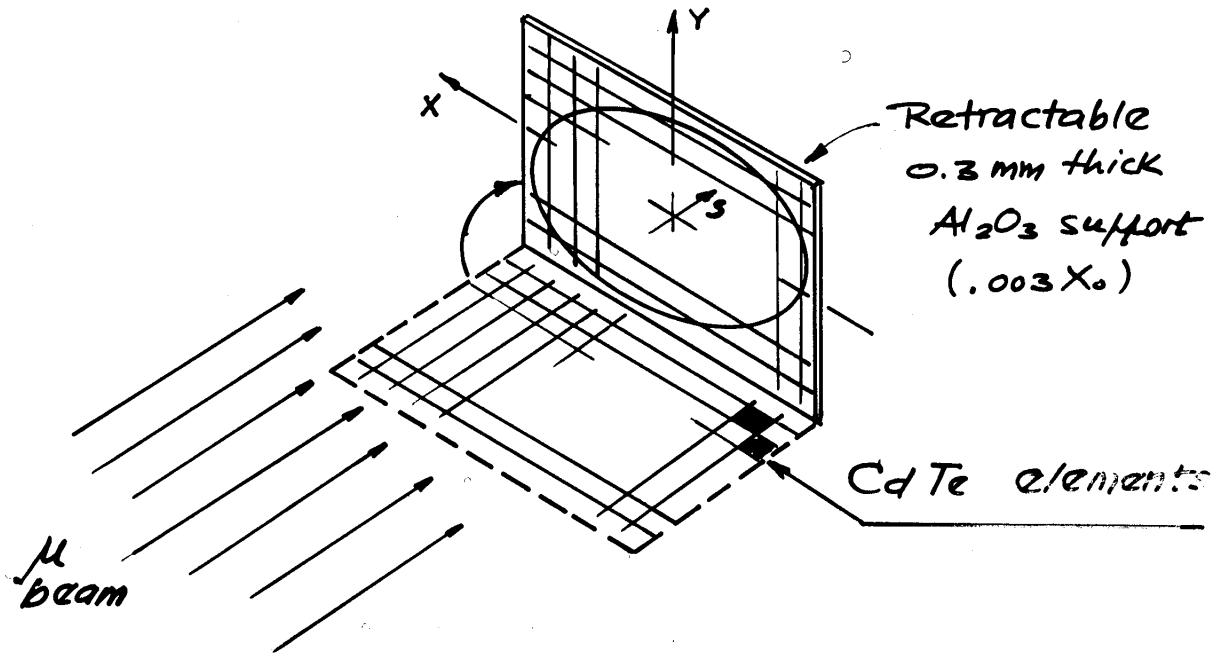


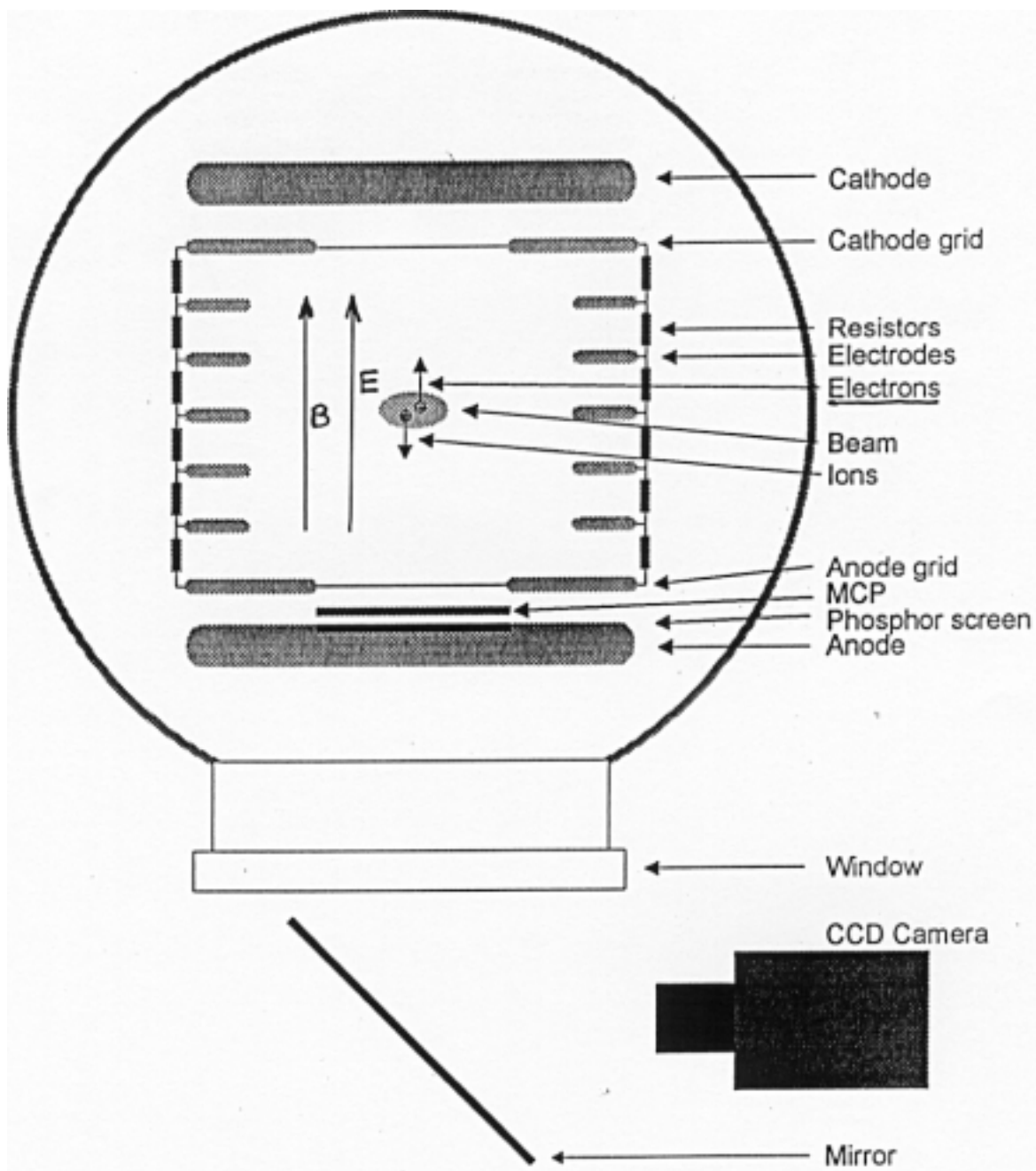
CdTe array configurations envisaged

for applications in LHC Lumi-monitors



CdTe array envisageable for μ -beam profile





DESY Restgas Ionisation Profile Monitor used at CERN

3- Conclusion

- **The signal response of Thick-polycrystalline-CdTe is sufficient for 40 MHz event rate measurement.**
- **The sensitivity of 10 000 electrons/MIP and the fast 50 ohms-preamplifier allows simple design.**
- **Irradiation-test up to 10^{15} Neutrons/cm² have demonstrate no significant loss in sensitivity or speed.**

Test with MIP (Sr90)

